

Search Notes**Application/Control No.**

09/933,038

Examiner

LEE NGUYEN

**Applicant(s)/Patent under
Reexamination**

FUTAGI ET AL.

Art Unit

2618

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--------------------------|------------|----------|
| 375 | 229 230 232 233 | 11/15/2006 | LN |
| | 266 | | |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST (USPG-PUB; USPAT; EPO; JPO; DERWENT) IEEE SEE SEARCH HISTORY | 11/15/2006 | LN |
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